CRMQGL1016A

N-Channel 100V, 13mΩ Typ. Power MOSFET

Description

Features

• 100V, 40A

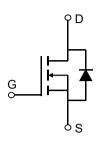
$$R_{DS(ON)}$$
 Typ = $13m\Omega$ @ V_{GS} = $10V$

 $R_{DS(ON)}$ Typ = 16.5m Ω @ V_{GS} = 4.5V

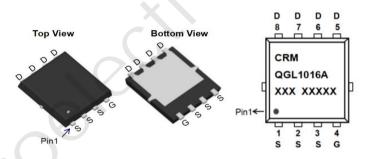
- Advanced Split Gate Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free
- 100% UIS TESTED!
- 100% ΔVds TESTED!

Application

- Load Switch
- PWM Application
- Power Management







Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMQGL1016A	CRMQGL1016A	PDFN3.3x3.3-8L	TAPING	13"	5000	50000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		100	V
V_{GS}	Gate-to-Source Voltage		±20	V
_	Continuous Drain Current	T _C = 25°C	40	Α
I _D	Continuous Drain Current	T _C = 100°C	24	А
I_{DM}	Pulsed Drain Current (1)		160	Α
E _{AS}	Single Pulsed Avalanche Energy (2)		56	mJ
P_{D}	Power Dissipation	T _C = 25°C	48	W
$R_{ heta JC}$	Thermal Resistance, Junction to Case		2.6	°C/W
T_{J}, T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C

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Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Uni
Off Chara	acteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 100V, V _{GS} = 0V	-	-	1.0	μΑ
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	acteristics				6	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2	1.8	2.5	V
Б	OL 1: D : 0 (3)	V _{GS} = 10V, I _D = 15A	-	13	17	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽³⁾	V _{GS} = 4.5V, I _D = 10A	-	16.5	21.5	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance			1130	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 50V,$ f = 1MHz	X-\	430	-	pF
C_{rss}	Reverse Transfer Capacitance	1 – 1101112		5.8	-	pF
Q_g	Total Gate Charge		J .	15.5	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 50V, I_{D} = 10A$	-	4	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} - 30 V, I _D - 10A	-	1.9	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime	.r ()	-	4.5	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 50V$	-	5.5	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	$I_D = 10A$, $R_{GEN} = 6\Omega$	-	16	-	ns
t_f	Turn-Off Fall Time		-	9	-	ns
Drain-So	urce Diode Characteristics and N	Max Ratings				
Is	Maximum Continuous Drain to Source Di	ode Forward Current	-	-	40	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	160	А
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _S = 15A	-	-	1.2	V
trr	Body Diode Reverse Recovery Time	1 - 454 - 40044	-	40	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 15A$, di/dt = 100A/us	_	32	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} E_{AS} condition: Starting T_J =25°C, V_{DD} =50V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =15A

^{3.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

Typical Performance Characteristics

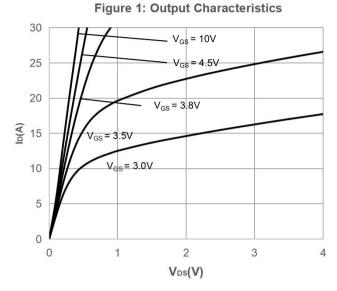


Figure 3: On-resistance vs. Drain Current

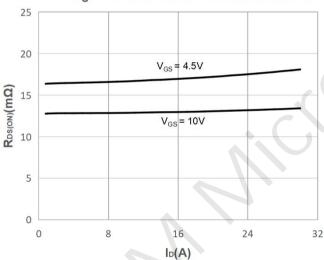


Figure 5: Gate Charge Characteristics

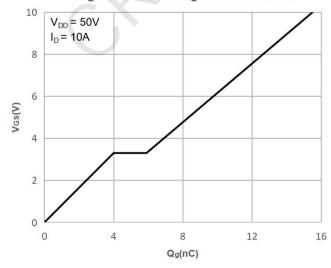


Figure 2: Typical Transfer Characteristics

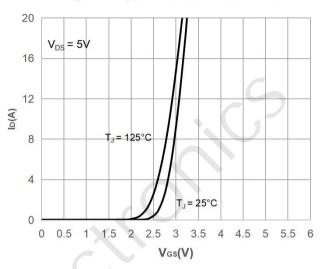


Figure 4: Body Diode Characteristics

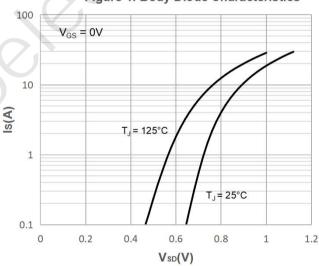
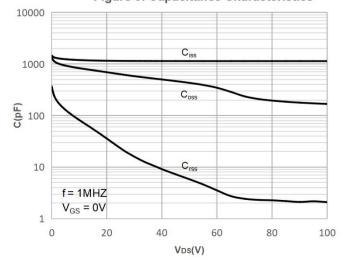


Figure 6: Capacitance Characteristics



Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs.
Junction Temperature

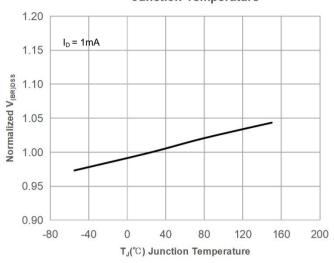


Figure 9: Maximum Safe Operating Area

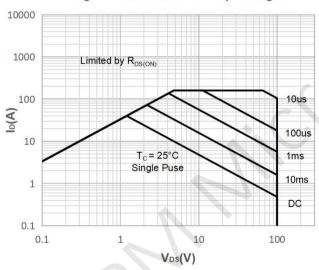


Figure 11: Normalized Maximum Transient

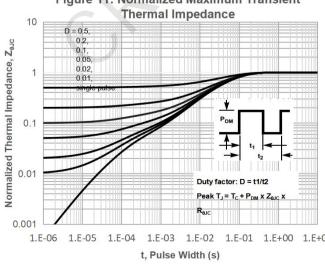


Figure 8: Normalized on Resistance vs.
Junction Temperature

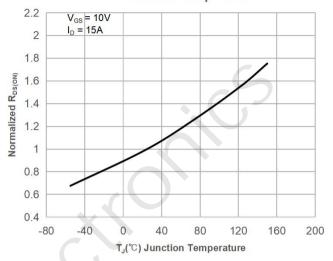


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

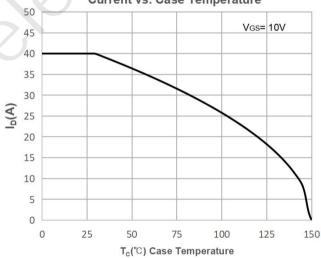
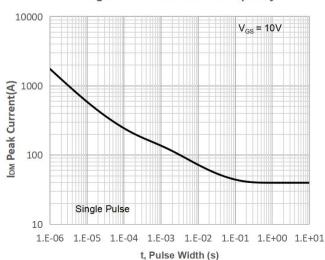


Figure 12: Peak Current Capacity



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Test Circuit

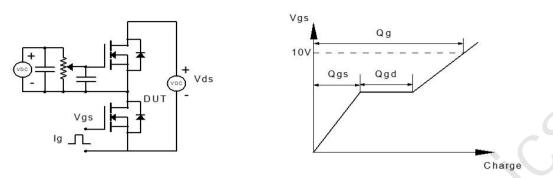


Figure 1: Gate Charge Test Circuit & Waveform

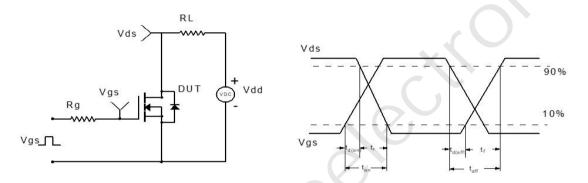


Figure 2: Resistive Switching Test Circuit & Waveform

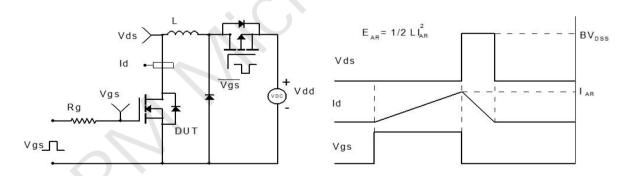


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

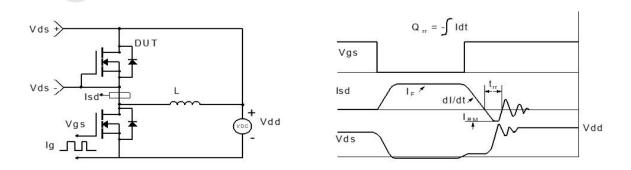
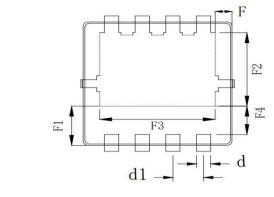


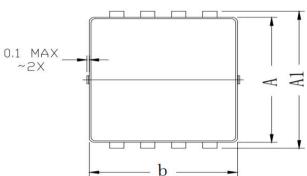
Figure 4: Diode Recovery Test Circuit & Waveform

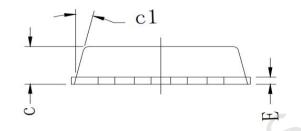
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Package Mechanical Data(PDFN3.3x3.3-8L)







	COMMON D	DIMENSION (MM)	
PKG	PDFN 3.3×3.3-8L		
SYMBOL	MIN	TYP	MAX
Α	3. 070	3.100	3.130
A1	3. 300	3.400	3.500
b	3.070	3.100	3.130
С	0.770	0.800	0.830
c1	_	13°	82
d	0. 275	0.300	0. 325
d1	0. 625	0.650	0. 675
Е	0. 144	0. 152	0. 160
F	0.300	0. 325	0. 350
F1	0. 960	0. 985	1.010
F2	1. 775	1. 800	1.825
F3	2. 425	2. 450	2. 475
F4	0.660	0. 685	0.710

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